Application/Control No.	Applicant(s)/Patent under Reexamination	
10/781,115	CRANDALL ET AL.	
Examiner	Art Unit	
Anthony Weier	1761	

SEARCHED					
Class	Subclass	Date	Examiner		
updated	previous search	3/16/2006	AW		
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
426	634, 658				
	577, 431	3/16/2006	AW		

SEARCH (INCLUDING SEAF		')
	DATE	EXMR
PGPub Text Search	3/16/2006	AW
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